

Notice of References Cited

Application/Control No.

09/759,524

Applicant(s)/Patent Under
Reexamination
YUAN ET AL.

Examiner

Peter B. Kim

Art Unit

2851

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0054280	05-2002	TOKUDA et al.	355/53
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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